

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination ENEBAKK ET AL.	
		Examiner Felisa C. Hiteshew	Art Unit 1792	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-4,247,528 A	01-1981	Dosaj et al.	117/11
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
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	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
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	S					
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Analysis of the silicon market: Will thin films profit?, Brandsen, G.W., et al, Energy Policy: Publisher: kidlington, (2007) ☐☐Vol. 35, No. 6, pgs 1-8
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.